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•	Application/Control No.	Applicant(s)/Patent und Reexamination	er
	10/033,406	ZHANG ET AL.	
	Examiner	Art Unit	
	Nitin C. Patel	2116	

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	SEARCHED		
Class	Subclass	Date	Examiner
713	300,320,3 22,323,32 4,330	4/25/2005	NCP
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
713	300,320,322	4/25/2005	NCP
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East 2.0.1, USPAT, USOCR, USPGPUB, IBM_TDB, EPO, JPO, DERWENT	4121195 4121195 4125705 512105 4125/80	7772
CONSUMED With pointer examinar Elamin A.	1/25/20	1
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